

Si9956DY

N-channel enhancement mode field-effect transistor

Rev. 01 — 16 July 2001

Product data

1. Description

Dual N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™¹ technology.

Product availability:

Si9956DY in SOT96-1 (SO8).

2. Features

- Low on-state resistance
- Fast switching
- TrenchMOS™ technology.

3. Applications

- DC to DC convertors
- DC motor control
- Lithium-ion battery applications
- Notebook PC
- Portable equipment applications.

4. Pinning information

Table 1: Pinning - SOT96-1, simplified outline and symbol

| Pin | Description | Simplified outline | Symbol |
|-----|----------------------------|--------------------|--------|
| 1 | source 1 (s ₁) | | |
| 2 | gate 1 (g ₁) | | |
| 3 | source 2 (s ₂) | | |
| 4 | gate 2 (g ₂) | | |
| 5,6 | drain 2 (d ₂) | | |
| 7,8 | drain 1 (d ₁) | | |

1. TrenchMOS is a trademark of Royal Philips Electronics.



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5. Quick reference data

Table 2: Quick reference data

| Symbol | Parameter | Conditions | Typ | Max | Unit |
|------------|----------------------------------|--|-----|-----|------|
| V_{DS} | drain-source voltage (DC) | $T_j = 25$ to 150 °C | – | 20 | V |
| I_D | drain current (DC) | $T_{amb} = 25$ °C; pulsed; $t_p \leq 10$ s | – | 3.5 | A |
| P_{tot} | total power dissipation | $T_{amb} = 25$ °C; pulsed; $t_p \leq 10$ s | – | 2 | W |
| T_j | junction temperature | | – | 150 | °C |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10$ V; $I_D = 2.2$ A | 55 | 100 | mΩ |
| | | $V_{GS} = 4.5$ V; $I_D = 1$ A | 70 | 200 | mΩ |

6. Limiting values

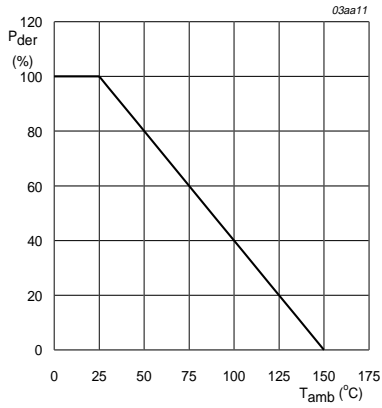
Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|--------------------------------|--|-----|------|------|
| V_{DS} | drain-source voltage (DC) | $T_j = 25$ to 150 °C | – | 20 | V |
| V_{GS} | gate-source voltage (DC) | | – | ±20 | V |
| I_D | drain current (DC) | $T_{amb} = 25$ °C; pulsed; $t_p \leq 10$ s; Figure 2 and 3 | – | 3.5 | A |
| | | $T_{amb} = 70$ °C; pulsed; $t_p \leq 10$ s; Figure 2 | – | 2.8 | A |
| I_{DM} | peak drain current | $T_{amb} = 25$ °C; pulsed; $t_p \leq 10$ μs; Figure 3 | – | 14 | A |
| P_{tot} | total power dissipation | $T_{amb} = 25$ °C; pulsed; $t_p \leq 10$ s; Figure 1 | – | 2 | W |
| | | $T_{amb} = 70$ °C; pulsed; $t_p \leq 10$ s; Figure 1 | – | 1.3 | W |
| T_{stg} | storage temperature | | –55 | +150 | °C |
| T_j | operating junction temperature | | –55 | +150 | °C |

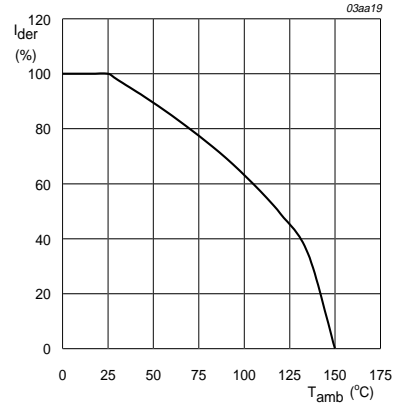
Source-drain diode

| | | | | | |
|-------|-------------------------------------|-------------------|---|-----|---|
| I_S | source (diode forward) current (DC) | $T_{amb} = 25$ °C | – | 1.3 | A |
|-------|-------------------------------------|-------------------|---|-----|---|



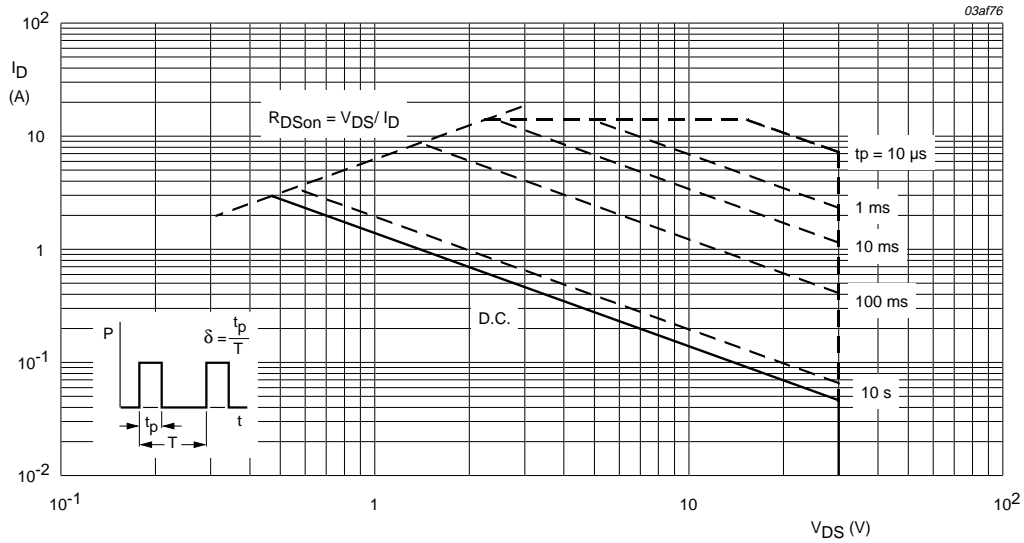
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



T_{amb} = 25 °C; I_{DM} is single pulse.

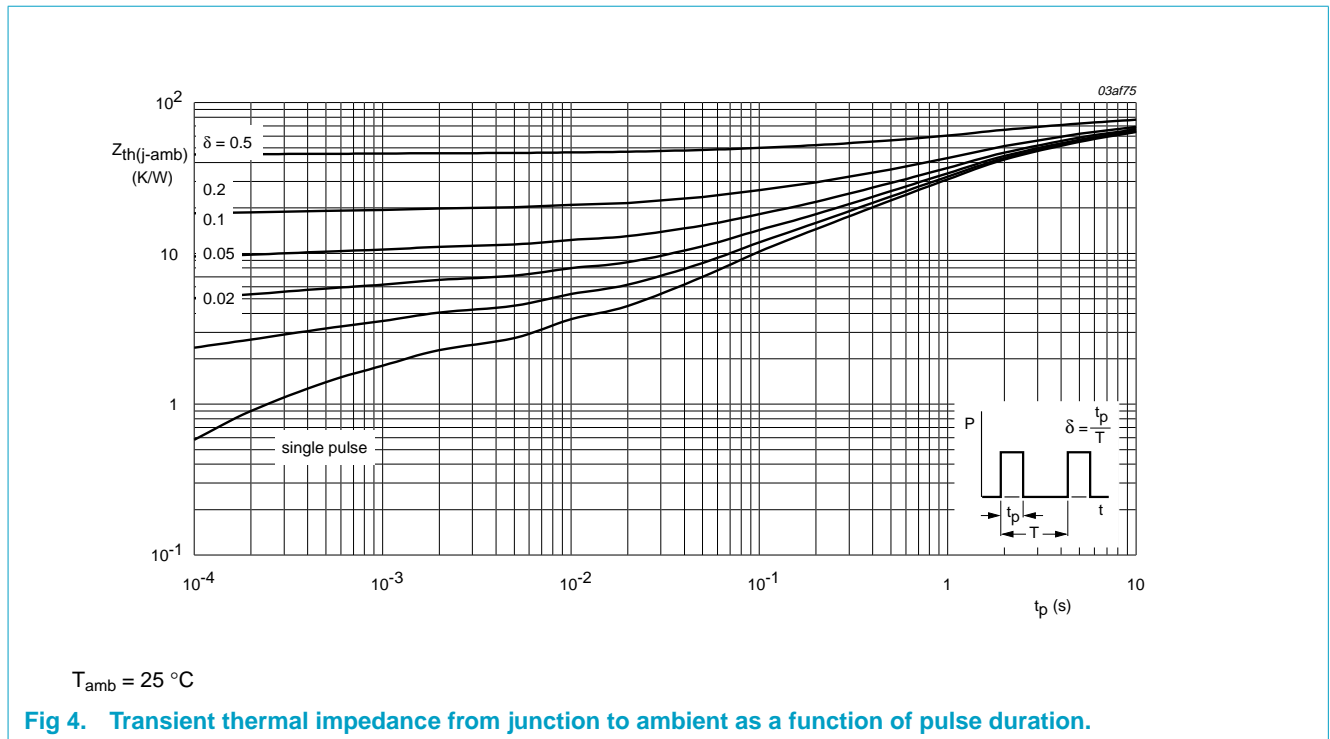
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

7. Thermal characteristics

Table 4: Thermal characteristics

| Symbol | Parameter | Conditions | Value | Unit |
|---------------|---|---|-------|------|
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | mounted on a printed circuit board; $t_p \leq 10$ s; minimum footprint; Figure 4 | 62.5 | K/W |

7.1 Transient thermal impedance

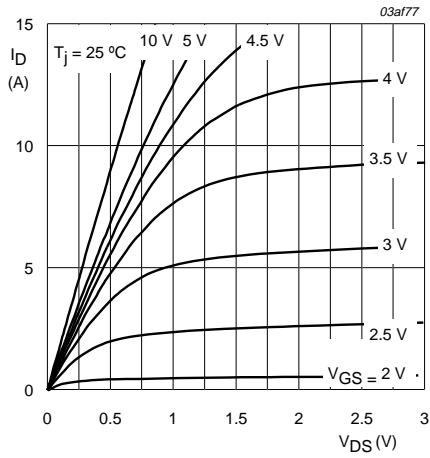


8. Characteristics

Table 5: Characteristics

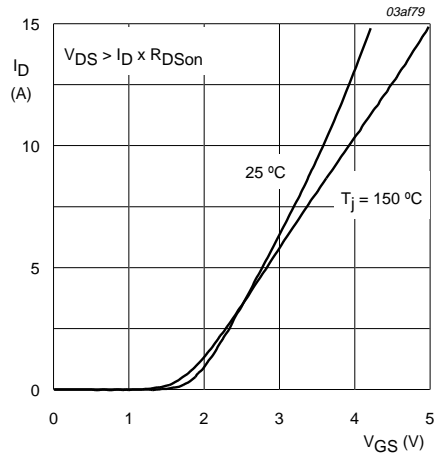
$T_j = 25\text{ °C}$ unless otherwise specified

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------------------------|--------------------------------------|--|-----|------|-----|---------------|
| Static characteristics | | | | | | |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 250\ \mu\text{A}$; $V_{DS} = V_{GS}$ | 1 | – | – | V |
| I_{DSS} | drain-source leakage current | $V_{DS} = 16\ \text{V}$; $V_{GS} = 0\ \text{V}$ | | | | |
| | | $T_j = 25\text{ °C}$ | – | – | 2 | μA |
| | | $T_j = 55\text{ °C}$ | – | – | 25 | μA |
| I_{GSS} | gate-source leakage current | $V_{GS} = \pm 20\ \text{V}$; $V_{DS} = 0\ \text{V}$ | – | – | 100 | nA |
| $R_{DS(on)}$ | drain-source on-state resistance | $V_{GS} = 10\ \text{V}$; $I_D = 2.2\ \text{A}$; Figure 7 and 8 | – | 55 | 100 | m Ω |
| | | $V_{GS} = 4.5\ \text{V}$; $I_D = 1\ \text{A}$; Figure 7 and 8 | – | 70 | 200 | m Ω |
| Dynamic characteristics | | | | | | |
| g_{fs} | forward transconductance | $V_{DS} = 15\ \text{V}$; $I_D = 3.5\ \text{A}$ | – | 5.7 | – | S |
| $Q_{g(tot)}$ | total gate charge | $I_D = 1.8\ \text{A}$; $V_{DS} = 10\ \text{V}$; $V_{GS} = 10\ \text{V}$; Figure 13 | – | 8 | 30 | nC |
| Q_{gs} | gate-source charge | | – | 0.8 | – | nC |
| Q_{gd} | gate-drain (Miller) charge | | – | 1.7 | – | nC |
| $t_{d(on)}$ | turn-on delay time | $V_{DD} = 10\ \text{V}$; $R_D = 10\ \Omega$; $V_{GS} = 10\ \text{V}$; $R_G = 6\ \Omega$ | – | 6 | 20 | ns |
| t_r | turn-on rise time | | – | 8 | 20 | ns |
| $t_{d(off)}$ | turn-off delay time | | – | 14 | 90 | ns |
| t_f | turn-off fall time | | – | 8 | 50 | ns |
| Source-drain (reverse) diode | | | | | | |
| V_{SD} | source-drain (diode forward) voltage | $I_S = 2.3\ \text{A}$; $V_{GS} = 0\ \text{V}$; Figure 12 | – | 0.75 | 1.2 | V |
| t_{rr} | reverse recovery time | $I_S = 1.7\ \text{A}$; $di_S/dt = -100\ \text{A}/\mu\text{s}$; $V_{GS} = 0\ \text{V}$ | – | 50 | 100 | ns |



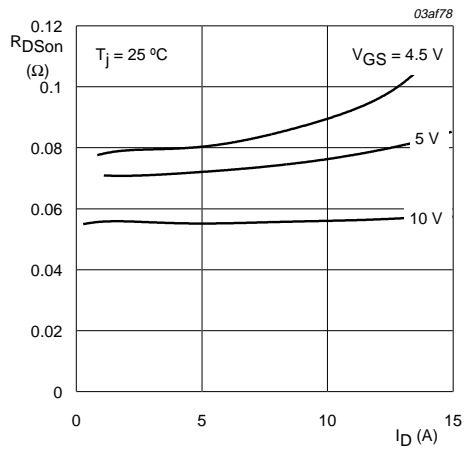
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



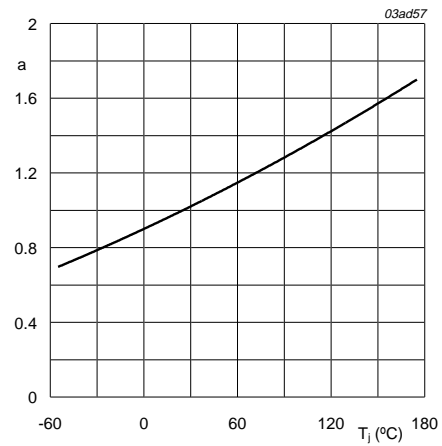
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



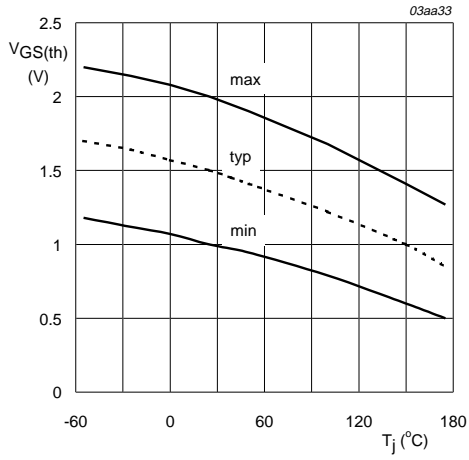
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



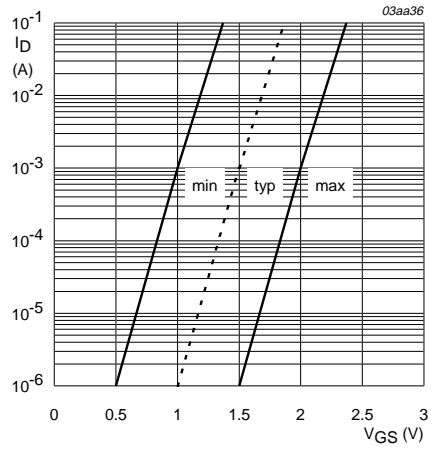
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



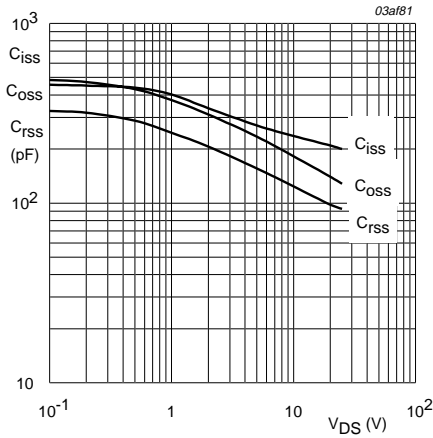
$I_D = 250 \mu\text{A}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



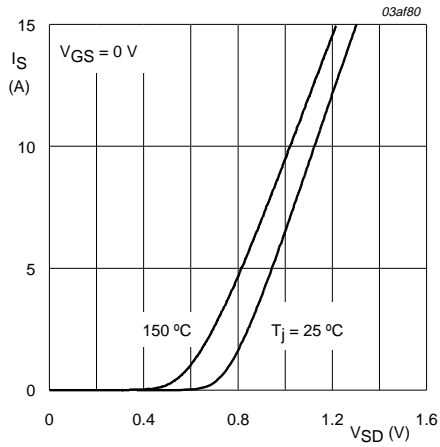
$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



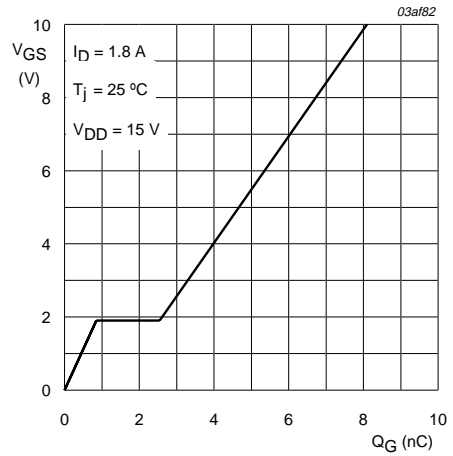
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25^\circ\text{C}$ and 150°C ; $V_{GS} = 0\text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 1.8\text{ A}$; $V_{DD} = 15\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.

9. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1

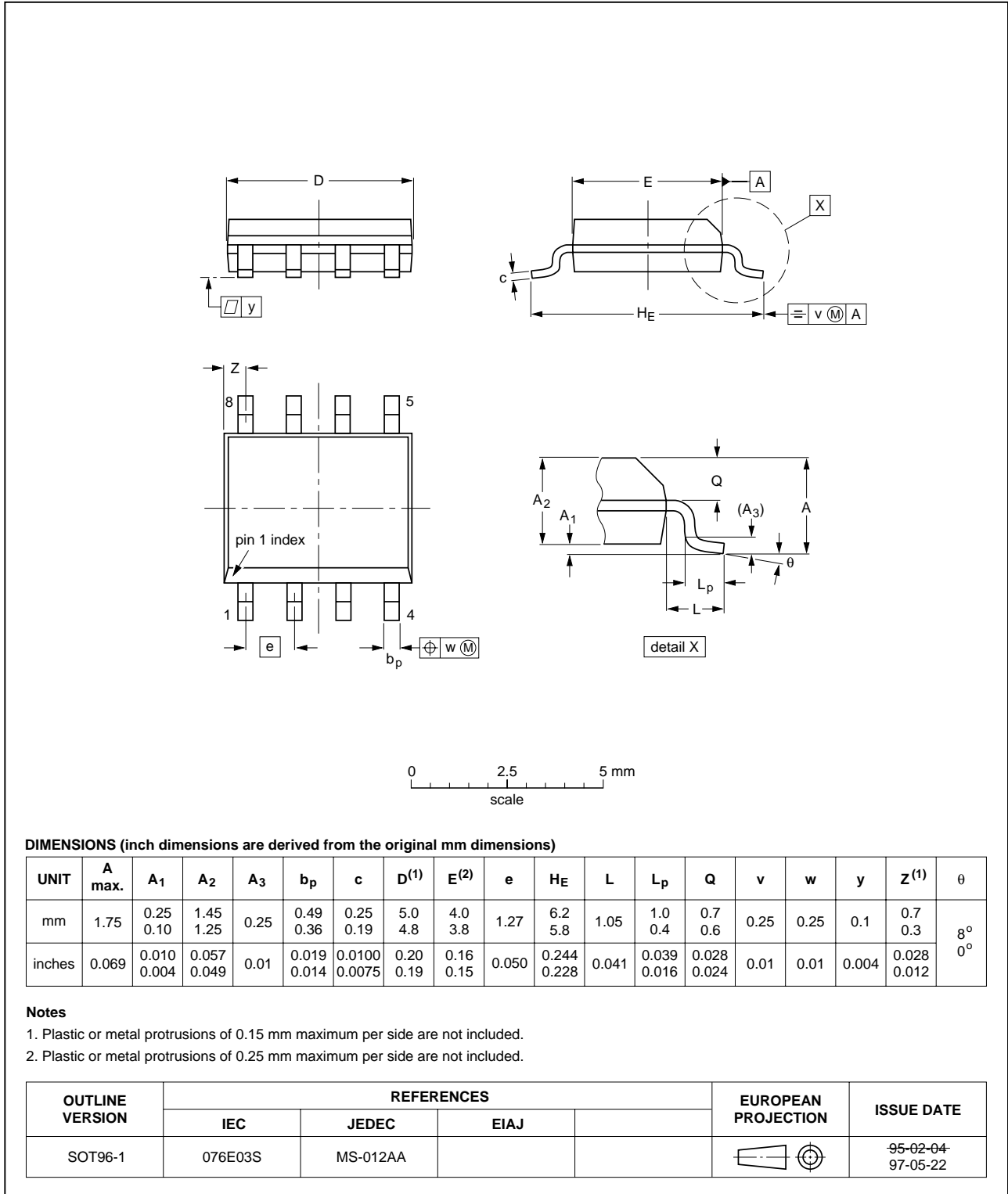


Fig 14. SOT96-1 (SO8).

10. Revision history

Table 6: Revision history

| Rev | Date | CPCN | Description |
|-----|----------|------|--|
| 01 | 20010716 | - | Product specification; initial version |

11. Data sheet status

| Data sheet status ^[1] | Product status ^[2] | Definition |
|----------------------------------|-------------------------------|--|
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

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